

# FDPF045N10A

## N-Channel PowerTrench® MOSFET

100 V, 164 A, 4.5 mΩ

### Features

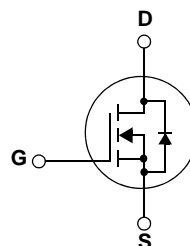
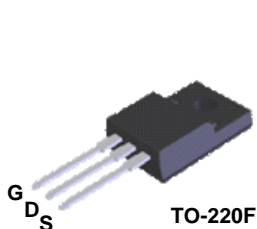
- $R_{DS(on)} = 3.7 \text{ m}\Omega$  (Typ.) @  $V_{GS} = 10 \text{ V}$ ,  $I_D = 67 \text{ A}$
- Fast Switching Speed
- Low Gate Charge,  $Q_G = 57 \text{ nC}$  (Typ.)
- High Performance Trench Technology for Extremely Low  $R_{DS(on)}$
- High Power and Current Handling Capability
- RoHS Compliant

### Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advance PowerTrench® process that has been tailored to minimize the on-state resistance while maintaining superior switching performance.

### Applications

- Synchronous Rectification for ATX / Server / Telecom PSU
- Motor drives and Uninterruptible Power Supplies
- Micro Solar Inverter



### MOSFET Maximum Ratings $T_C = 25^\circ\text{C}$ unless otherwise noted\*

| Symbol         | Parameter  | FDPF045N10A                                | Unit               |
|----------------|--|--|--------------------|
| $V_{DSS}$      | Drain to Source Voltage  | 100  | V                  |
| $V_{GSS}$      | Gate to Source Voltage   | $\pm 20$                                   | V                  |
| $I_D$          | Drain Current  | - Continuous ( $T_C = 25^\circ\text{C}$ )  | A                  |
|                |  | - Continuous ( $T_C = 100^\circ\text{C}$ ) |                    |
| $I_{DM}$       | Drain Current  | - Pulsed (Note 1)                          | A                  |
| $E_{AS}$       | Single Pulsed Avalanche Energy   | (Note 2)                                   | mJ                 |
| $dv/dt$        | Peak Diode Recovery $dv/dt$  | (Note 3)                                   | V/ns               |
| $P_D$          | Power Dissipation  | ( $T_C = 25^\circ\text{C}$ )               | W                  |
|                |  | - Derate above $25^\circ\text{C}$          | $W/^\circ\text{C}$ |
| $T_J, T_{STG}$ | Operating and Storage Temperature Range                                      | -55 to +175                                | $^\circ\text{C}$   |
| $T_L$          | Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds | 300  | $^\circ\text{C}$   |

### Thermal Characteristics

| Symbol          | Parameter                                     | FDPF045N10A | Unit               |
|-----------------|---|-------------|--------------------|
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case, Max.    | 3.5         | $^\circ\text{C/W}$ |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient, Max. | 62.5        |                    |

## Package Marking and Ordering Information

| Device Marking | Device      | Package | Reel Size | Tape Width | Quantity |
|----------------|-------------|---------|-----------|------------|----------|
| FDPF045N10A    | FDPF045N10A | TO-220F | -         | -          | 50       |

## Electrical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|--------|-----------|-----------------|------|------|------|------|
|--------|-----------|-----------------|------|------|------|------|

### Off Characteristics

|                                      |   |   |     |      |           |                           |
|--------------------------------------|---|---|-----|------|-----------|---------------------------|
| $BV_{DSS}$                           | Drain to Source Breakdown Voltage         | $I_D = 250\mu\text{A}$ , $V_{GS} = 0\text{V}$             | 100 | -    | -         | V                         |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $I_D = 250\mu\text{A}$ , Referenced to $25^\circ\text{C}$ | -   | 0.06 | -         | $\text{V}/^\circ\text{C}$ |
| $I_{DSS}$                            | Zero Gate Voltage Drain Current           | $V_{DS} = 80\text{V}$ , $V_{GS} = 0\text{V}$              | -   | -    | 1         | $\mu\text{A}$             |
|                                      |   | $V_{DS} = 80\text{V}$ , $T_C = 150^\circ\text{C}$         | -   | -    | 500       |                           |
| $I_{GSS}$                            | Gate to Body Leakage Current              | $V_{GS} = \pm 20\text{V}$ , $V_{DS} = 0\text{V}$          | -   | -    | $\pm 100$ | nA                        |

### On Characteristics

|              |                                      |  |     |     |     |                  |
|--------------|--------------------------------------|--|-----|-----|-----|------------------|
| $V_{GS(th)}$ | Gate Threshold Voltage               | $V_{GS} = V_{DS}$ , $I_D = 250\mu\text{A}$ | 2.0 | -   | 4.0 | V                |
| $R_{DS(on)}$ | Static Drain to Source On Resistance | $V_{GS} = 10\text{V}$ , $I_D = 67\text{A}$ | -   | 3.7 | 4.5 | $\text{m}\Omega$ |
| $g_{FS}$     | Forward Transconductance             | $V_{DS} = 10\text{V}$ , $I_D = 67\text{A}$ | -   | 127 | -   | S                |

### Dynamic Characteristics

|               |                                   |  |   |      |      |    |
|---------------|-----------------------------------|--|---|------|------|----|
| $C_{iss}$     | Input Capacitance                 | $V_{DS} = 50\text{V}$ , $V_{GS} = 0\text{V}$<br>$f = 1\text{MHz}$    | - | 3961 | 5270 | pF |
| $C_{oss}$     | Output Capacitance                |  | - | 925  | 1230 | pF |
| $C_{rss}$     | Reverse Transfer Capacitance      |  | - | 34   | -    | pF |
| $C_{oss(er)}$ | Energy Related Output Capacitance | $V_{DS} = 50\text{V}$ , $V_{GS} = 0\text{V}$                         | - | 1521 | -    | pF |
| $Q_{g(tot)}$  | Total Gate Charge at 10V          | $V_{GS} = 10\text{V}$ , $V_{DS} = 50\text{V}$<br>$I_D = 100\text{A}$ | - | 57   | 74   | nC |
| $Q_{gs}$      | Gate to Source Gate Charge        |  | - | 17   | -    | nC |
| $Q_{gs2}$     | Gate Charge Threshold to Plateau  |  | - | 8    | -    | nC |
| $Q_{gd}$      | Gate to Drain "Miller" Charge     |  | - | 13   | -    | nC |

### Switching Characteristics

|              |                                    |  |   |     |     |          |
|--------------|------------------------------------|--|---|-----|-----|----------|
| $t_{d(on)}$  | Turn-On Delay Time                 | $V_{DD} = 50\text{V}$ , $I_D = 100\text{A}$<br>$V_{GS} = 10\text{V}$ , $R_{GEN} = 4.7\Omega$<br>(Note 4) | - | 23  | 56  | ns       |
| $t_r$        | Turn-On Rise Time                  |  | - | 26  | 62  | ns       |
| $t_{d(off)}$ | Turn-Off Delay Time                |  | - | 50  | 110 | ns       |
| $t_f$        | Turn-Off Fall Time                 |  | - | 15  | 40  | ns       |
| ESR          | Equivalent Series Resistance (G-S) | $f = 1\text{MHz}$  | - | 1.9 | -   | $\Omega$ |

### Drain-Source Diode Characteristics

|                 |  |  |   |     |     |     |    |
|-----------------|--|--|---|-----|-----|-----|----|
| I <sub>S</sub>  | Maximum Continuous Drain to Source Diode Forward Current | -  | - | 67  | A   |     |    |
| I <sub>SM</sub> | Maximum Pulsed Drain to Source Diode Forward Current     | -  | - | 268 | A   |     |    |
| V <sub>SD</sub> | Drain to Source Diode Forward Voltage                    | V <sub>GS</sub> = 0V, I <sub>SD</sub> = 67A  |   | -   | -   | 1.3 | V  |
| t <sub>rr</sub> | Reverse Recovery Time                                    | V <sub>GS</sub> = 0V, V <sub>DD</sub> = 50V, I <sub>SD</sub> = 100A<br>dI <sub>F</sub> /dt = 100A/μs |   | -   | 75  | -   | ns |
| Q <sub>rr</sub> | Reverse Recovery Charge                                  |  |   | -   | 120 | -   | nC |

#### Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2.  $L = 3\text{mH}$ ,  $I_{AS} = 20.6\text{A}$ ,  $R_G = 25\Omega$ , Starting  $T_J = 25^\circ\text{C}$
3.  $I_{SD} \leq 100\text{A}$ ,  $di/dt \leq 200\text{A}/\mu\text{s}$ ,  $V_{DD} \leq BV_{DSS}$ , Starting  $T_J = 25^\circ\text{C}$
4. Essentially Independent of Operating Temperature Typical Characteristics

# Typical Performance Characteristics

Figure 1. On-Region Characteristics

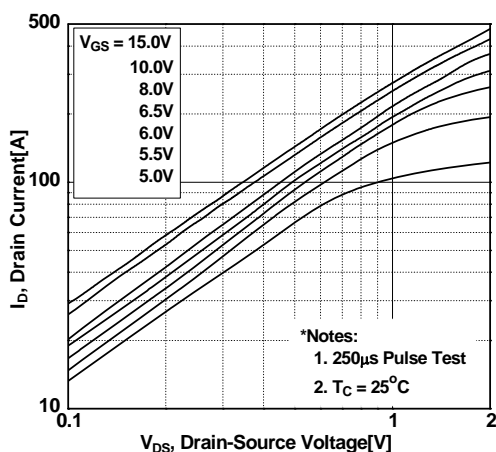


Figure 2. Transfer Characteristics

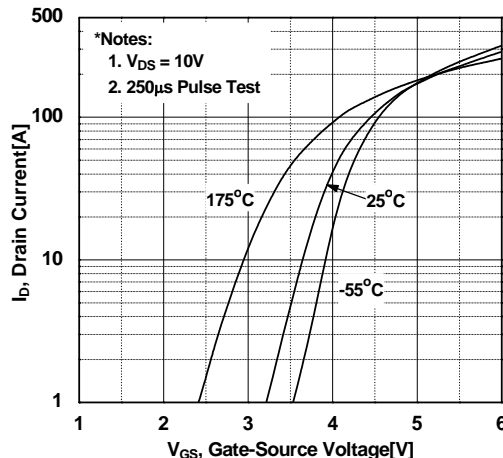


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

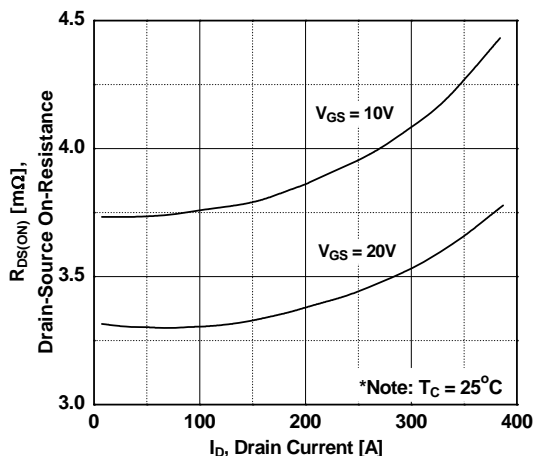


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

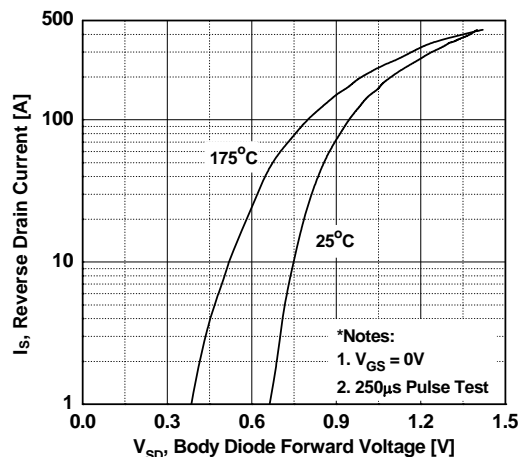


Figure 5. Capacitance Characteristics

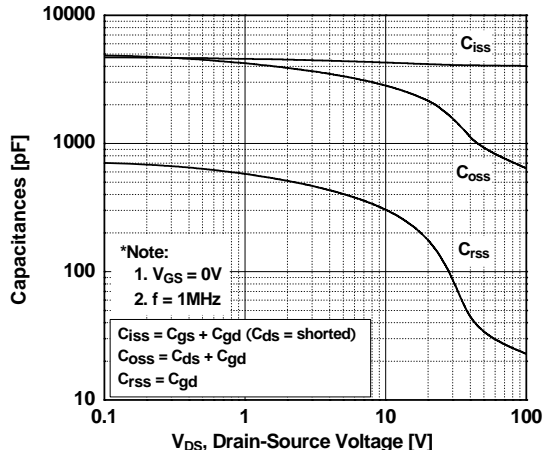
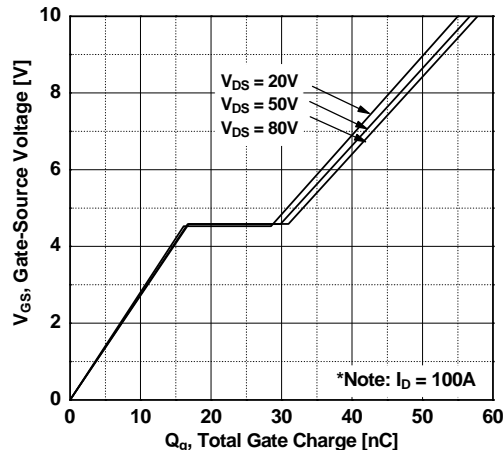
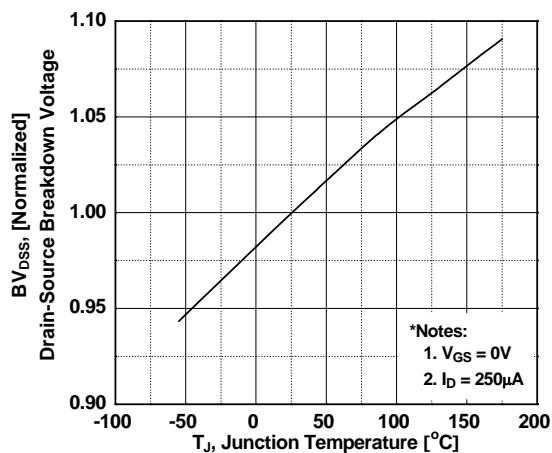


Figure 6. Gate Charge Characteristics

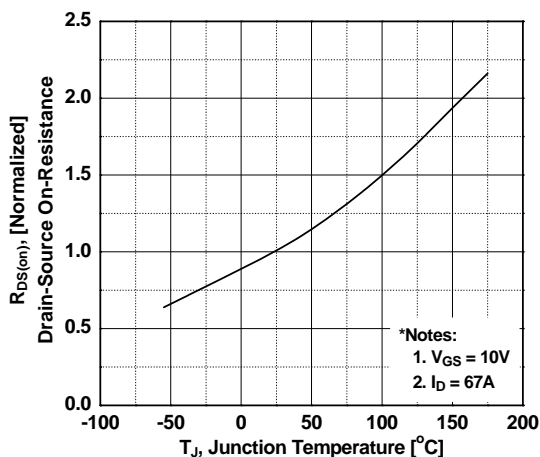


# Typical Performance Characteristics (Continued)

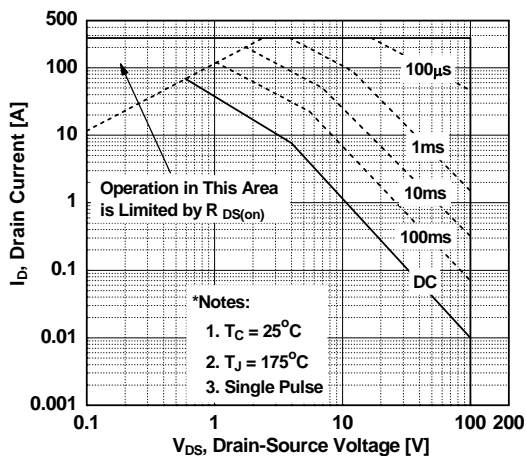
**Figure 7. Breakdown Voltage Variation vs. Temperature**



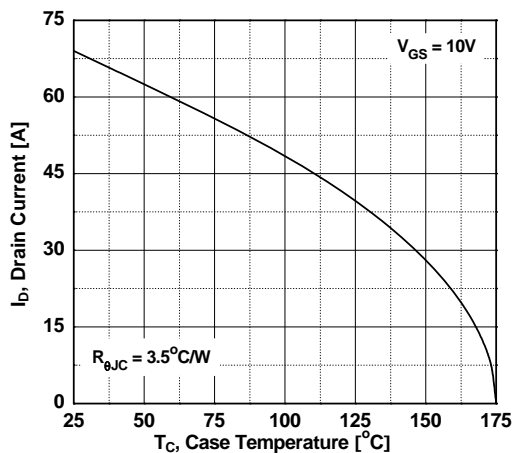
**Figure 8. On-Resistance Variation vs. Temperature**



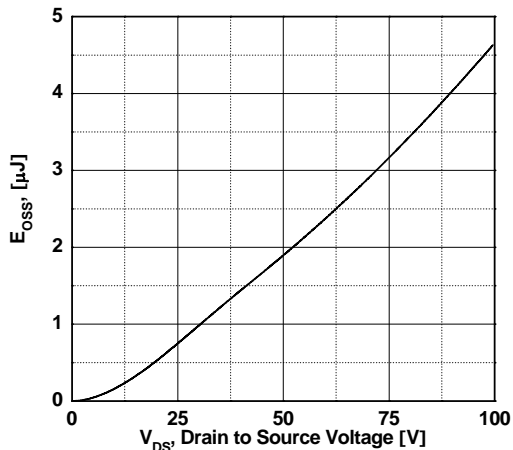
**Figure 9. Maximum Safe Operating Area vs. Case Temperature**



**Figure 10. Maximum Drain Current**

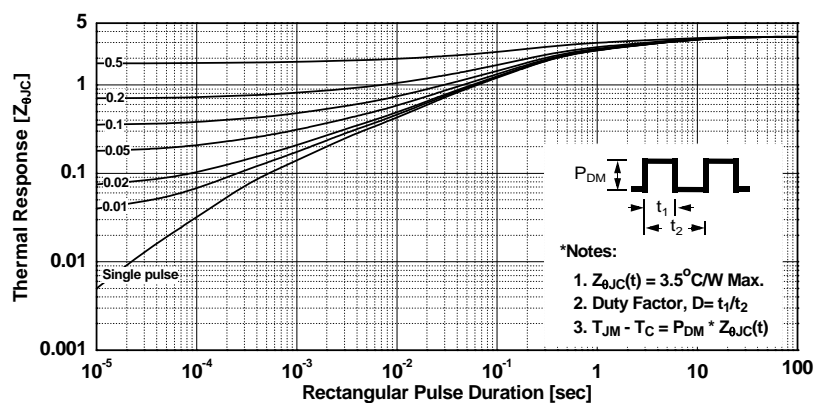


**Figure 11. Eoss vs. Drain to Source Voltage**



# Typical Performance Characteristics (Continued)

Figure 12. Transient Thermal Response Curve



Gate Charge Test Circuit & Waveform



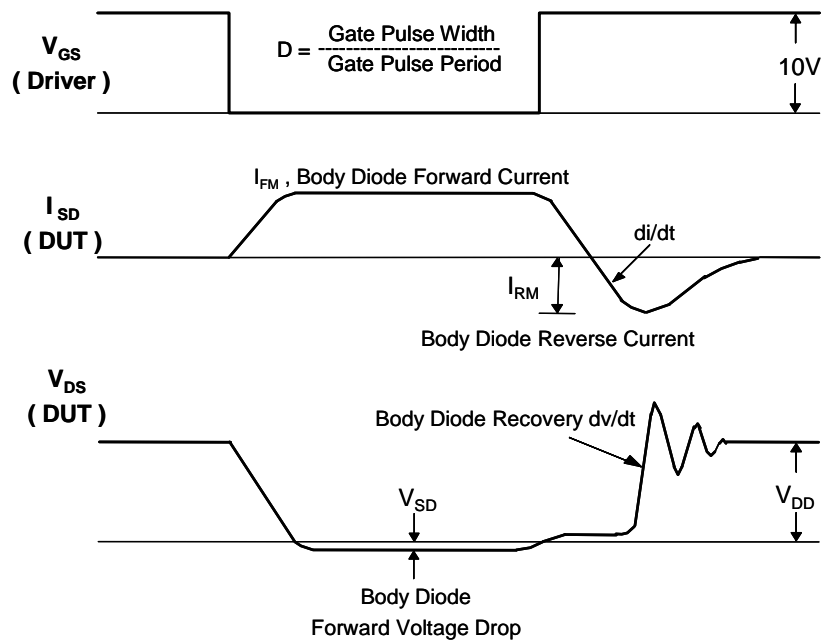
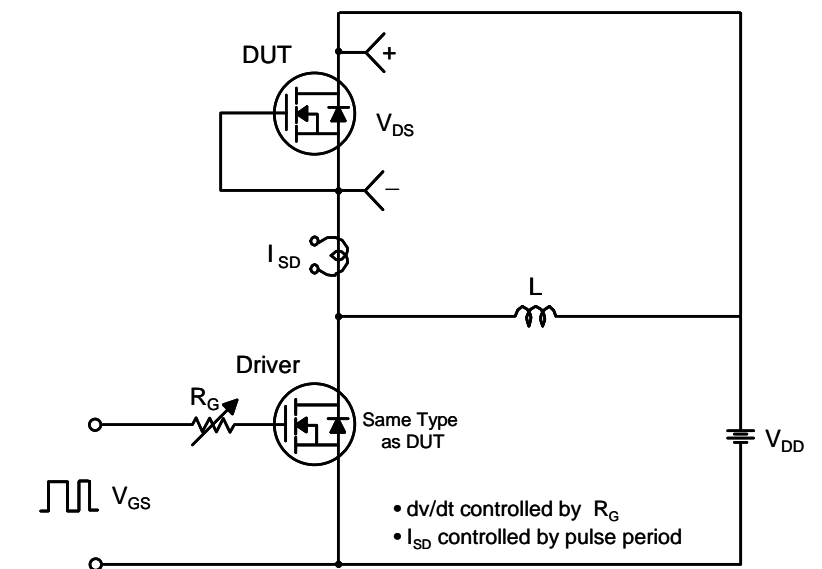
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms

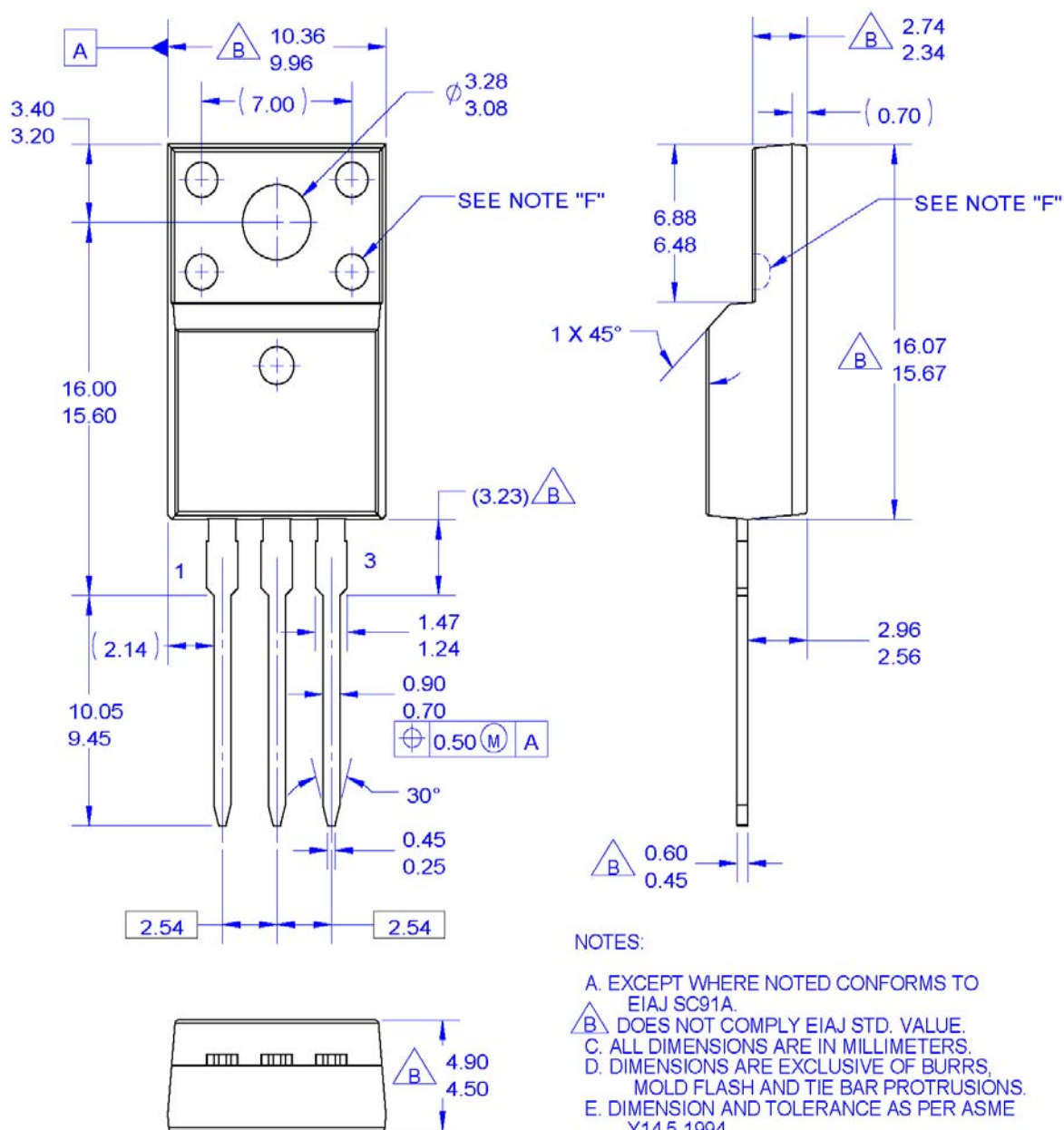


# Peak Diode Recovery dv/dt Test Circuit & Waveforms



# Mechanical Dimensions

## TO-220M03



### NOTES:

- A. EXCEPT WHERE NOTED CONFORMS TO EIAJ SC91A.
- B. DOES NOT COMPLY EIAJ STD. VALUE.
- C. ALL DIMENSIONS ARE IN MILLIMETERS.
- D. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.
- E. DIMENSION AND TOLERANCE AS PER ASME Y14.5-1994.
- F. OPTION 1 - WITH SUPPORT PIN HOLE.  
OPTION 2 - NO SUPPORT PIN HOLE.
- G. DRAWING FILE NAME: TO220M03REV3

Dimensions in Millimeters



